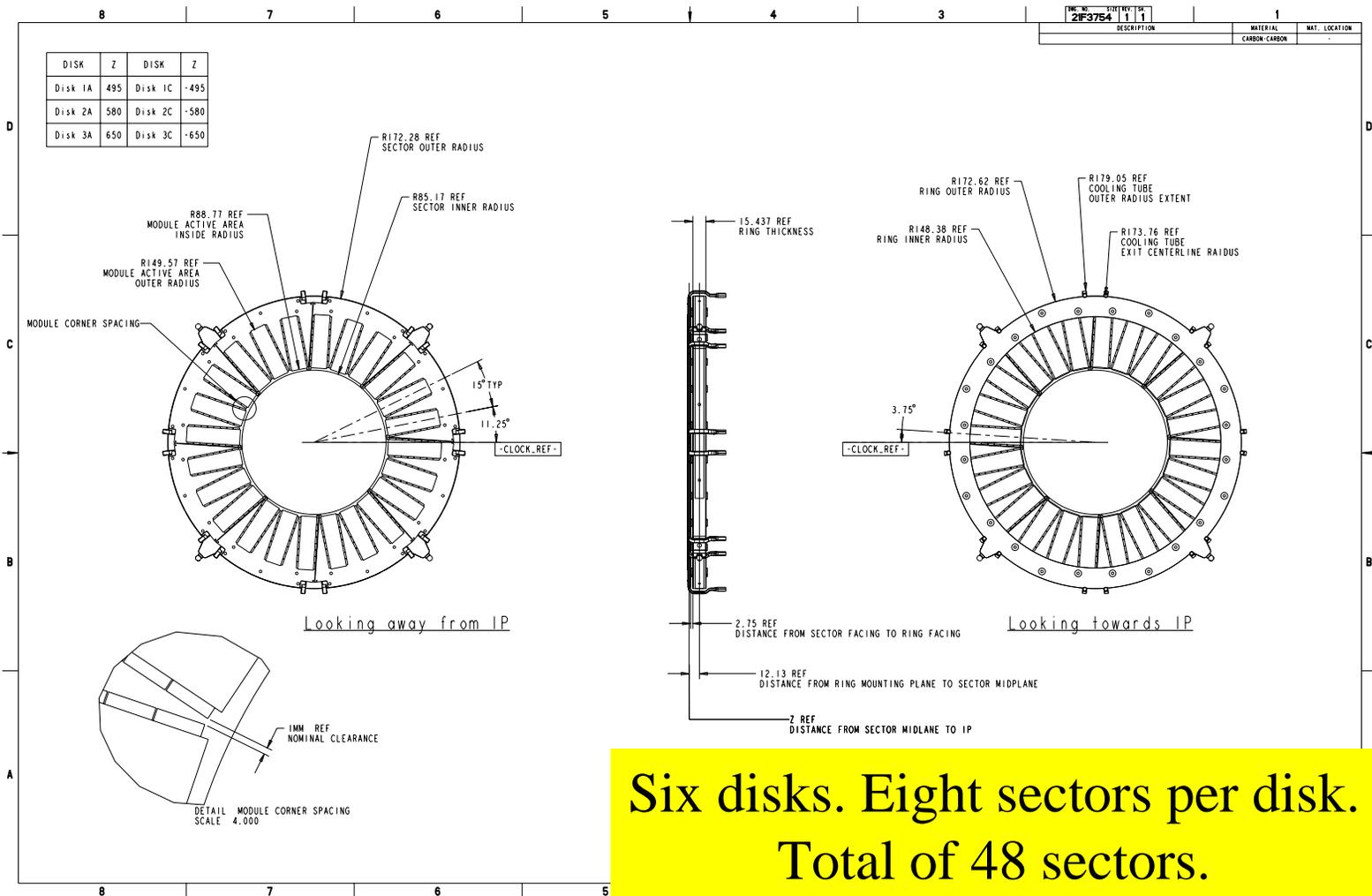

Disk Sector Status

Pixel Local Supports
Conceptual Design Review

Overview

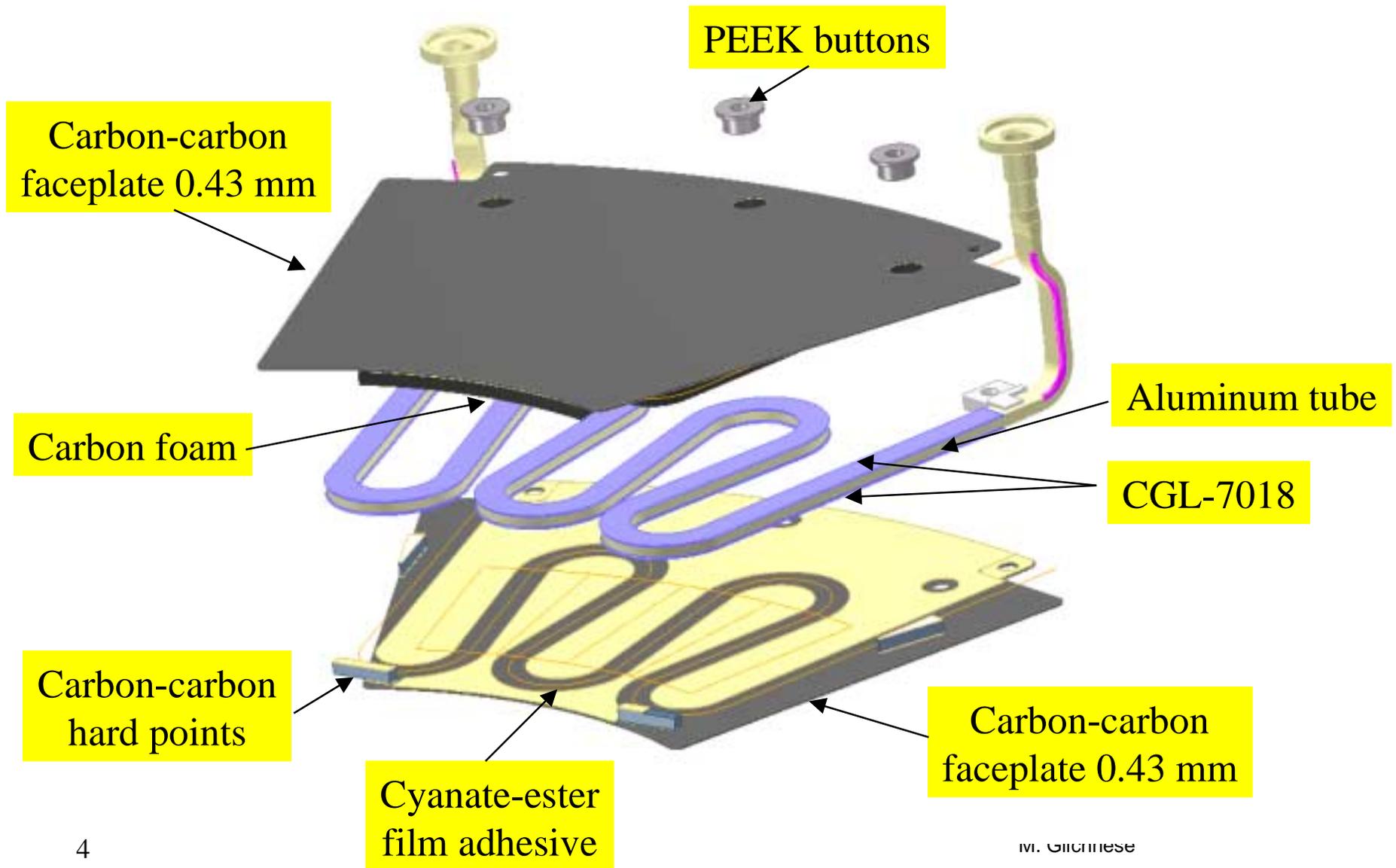
- The pixel layout has been changed substantially since the Local Support FDR last year.
- The sector dimensions have changed correspondingly.
- A baseline design was confirmed after the FDR last year.
- Evaluation of the design against requirements has been completed by testing of prototypes and by (FEA) calculations.

Disks



**Six disks. Eight sectors per disk.
Total of 48 sectors.**

Disk Sector Concept



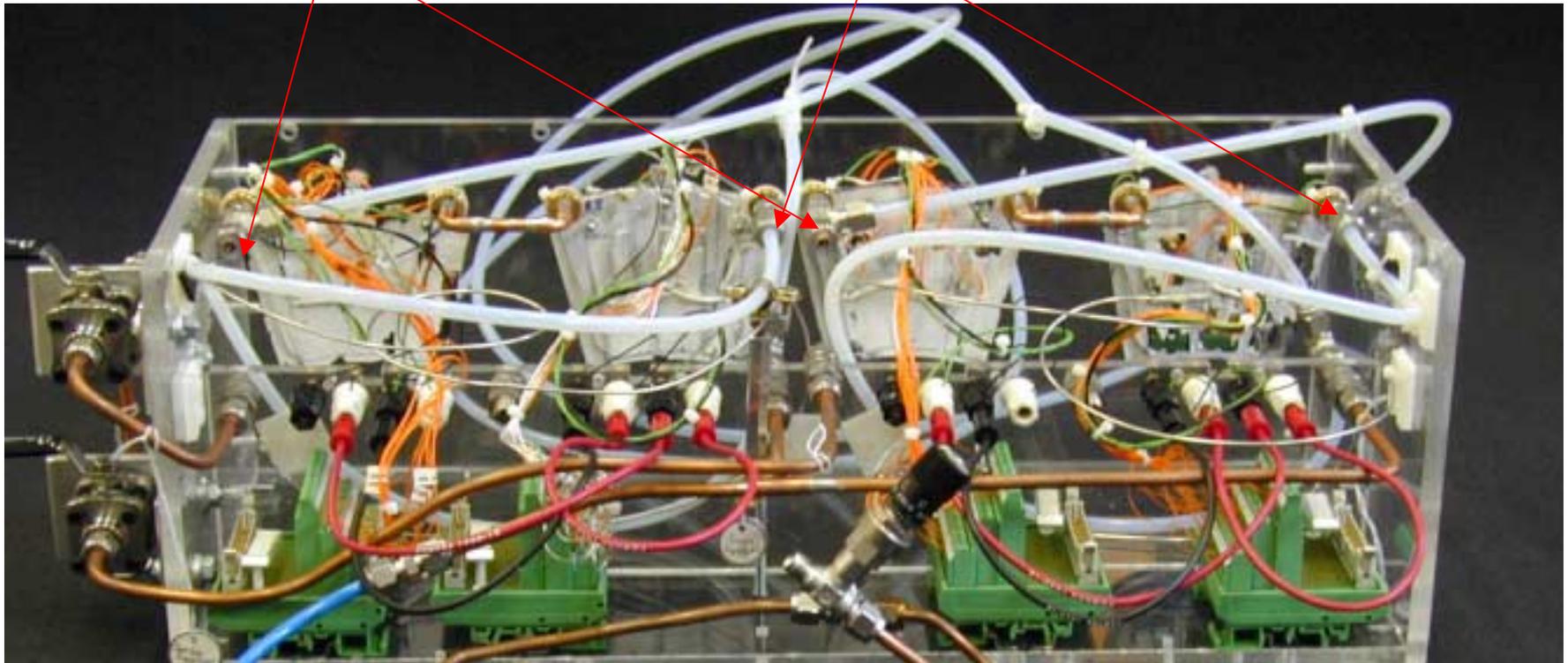
Since the FDR

- Most of the design requirements had been validated by the time of the FDR last year and were summarized in ATL-IP-ER-0004.
- Since the FDR
 - additional prototypes made(to current baseline dimensions)
 - sectors have been run with evaporative C_3F_8 coolant
 - thermal performance has been (re)validated after irradiation, thermal cycling, thermal shock, pressure fault conditions, loss of coolant.
 - stability calculations(FEA) performed, TV holography measurements
 - materials exposed to C_3F_8 vapor without degradation of performance
- Design is robust.
- Requirements met.

Evaporative Cooling Test

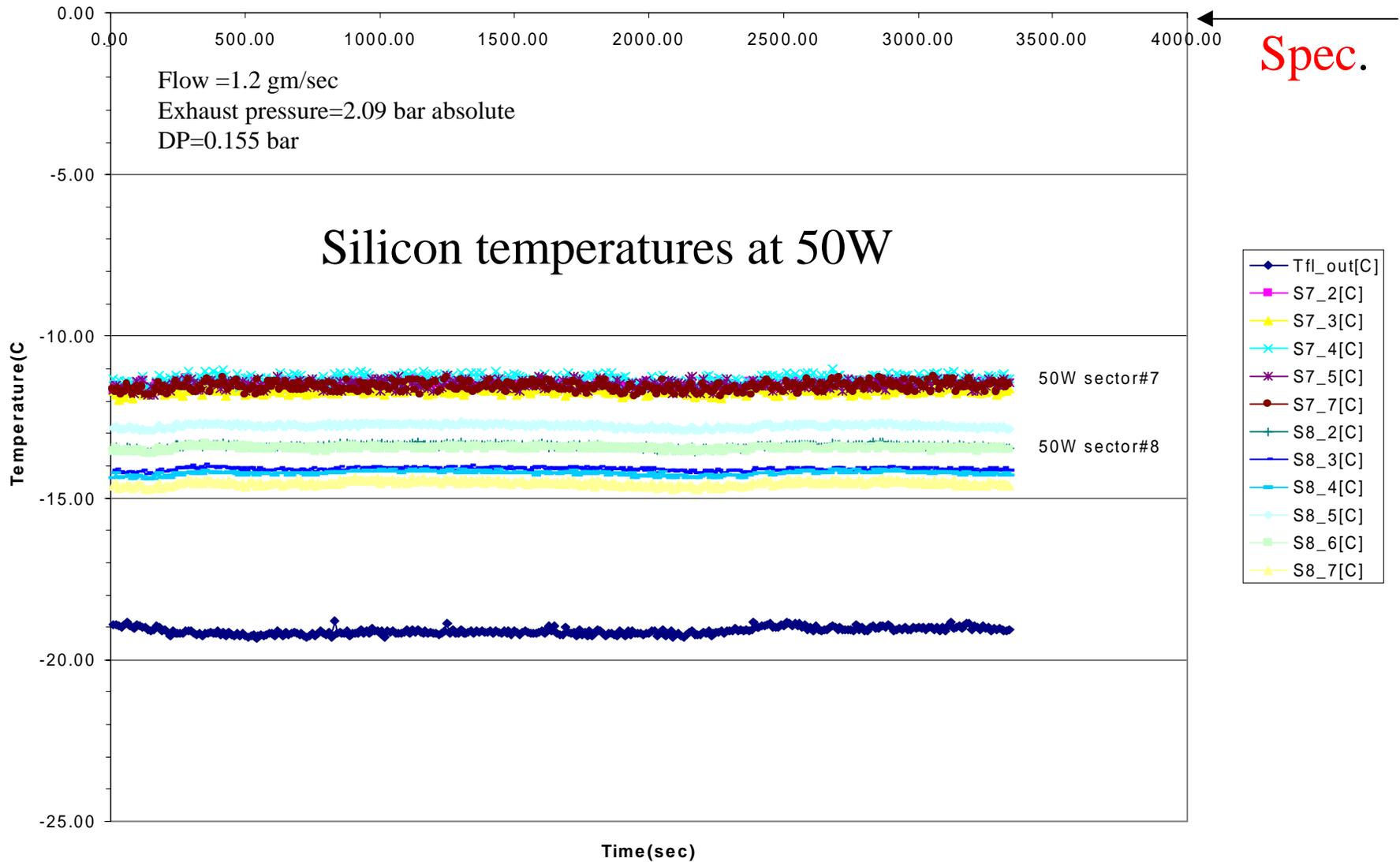
Capillary(0.030" ID
1.2 m long)

Exhaust lines

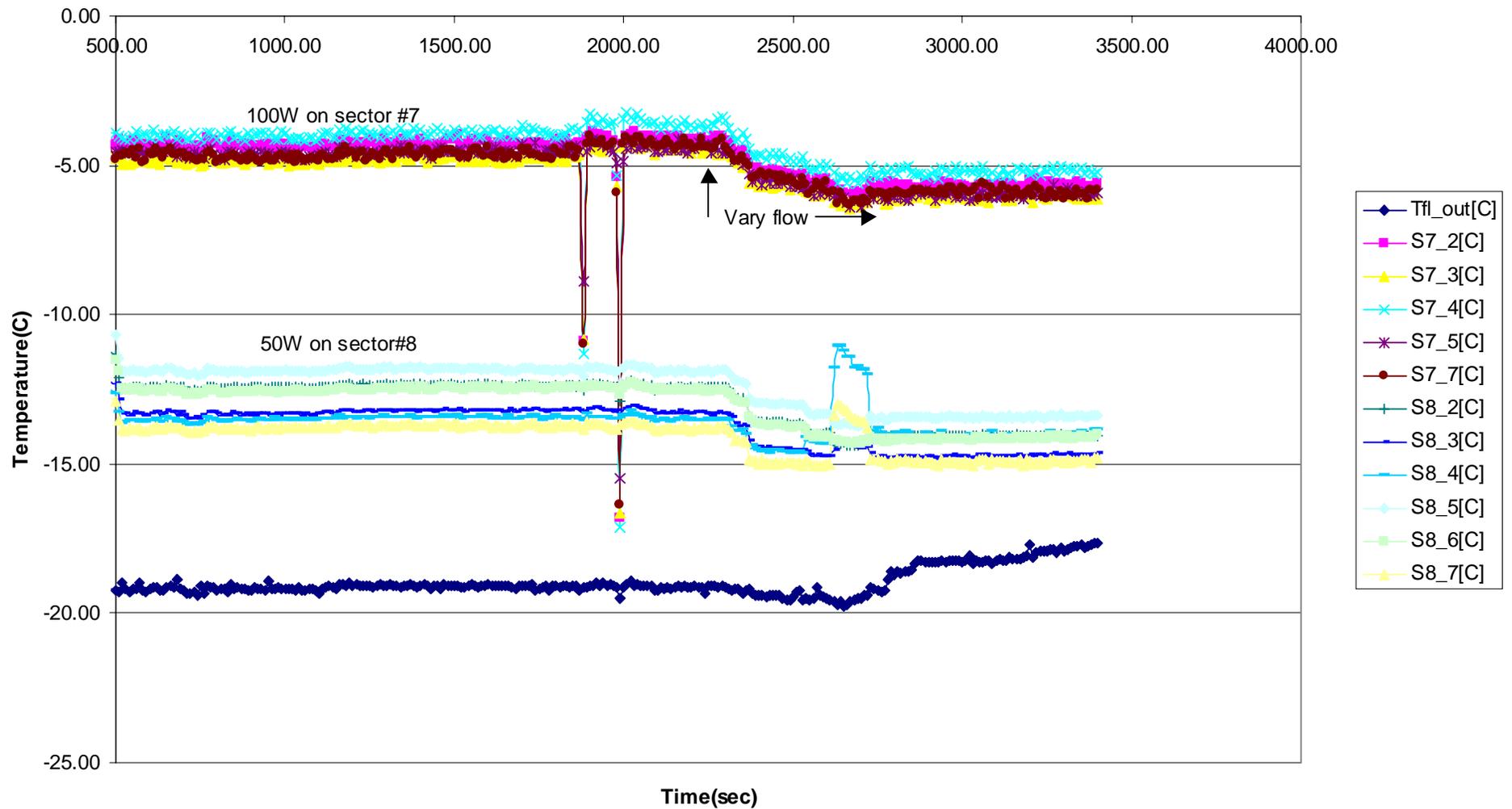


- This shows four aluminum-tube sectors. There are two pairs, running the pair in series. Two valves allow running each pair separately or running both pairs in parallel.
- Temperature recorded at multiple locations on each sector.
- Results at http://www-physics.lbl.gov/~gilg/Evaporative%20Tests/GIL_0600/ResultsJune00.ppt

Two Sectors in Series - Baseline

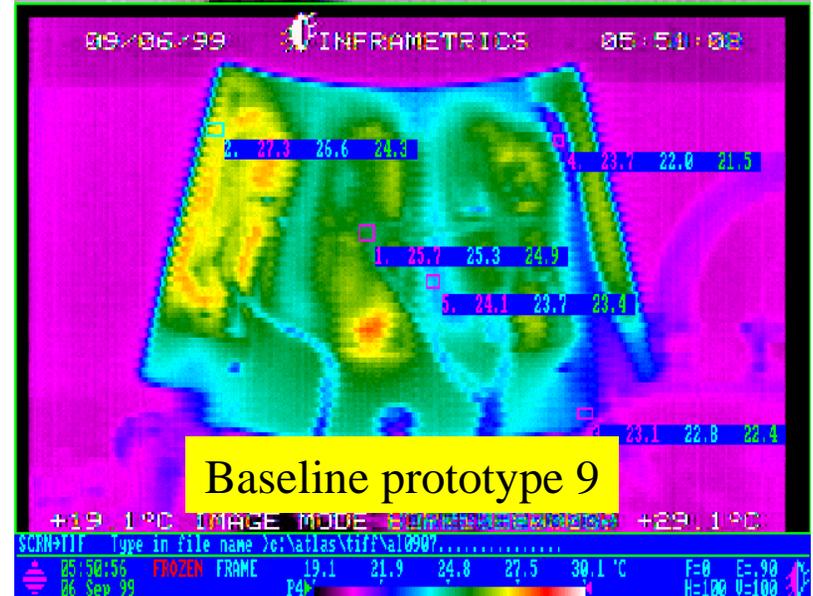
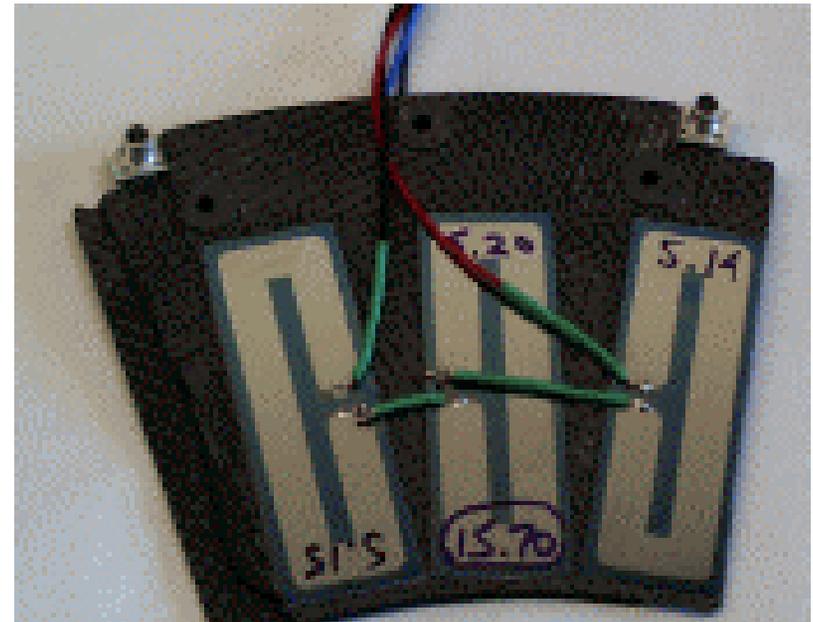


Operating Margin



Thermal Performance

- Thermal performance is measured using IR thermography and room temperature water coolant.
- Heat loads are simulated using Pt-on-silicon heaters that replicate distribution of expected heat.
- “Stress” testing has been done on multiple prototypes
 - 50+ thermal cycles 20C<->-35C
 - Thermal shock using LN2 vapor (and also C₃F₈)
 - Pressure to 8 bar absolute
 - Loss of coolant
 - Irradiation up to 50 Mrad (followed by other stress testing).
- Good consistency for different prototypes.

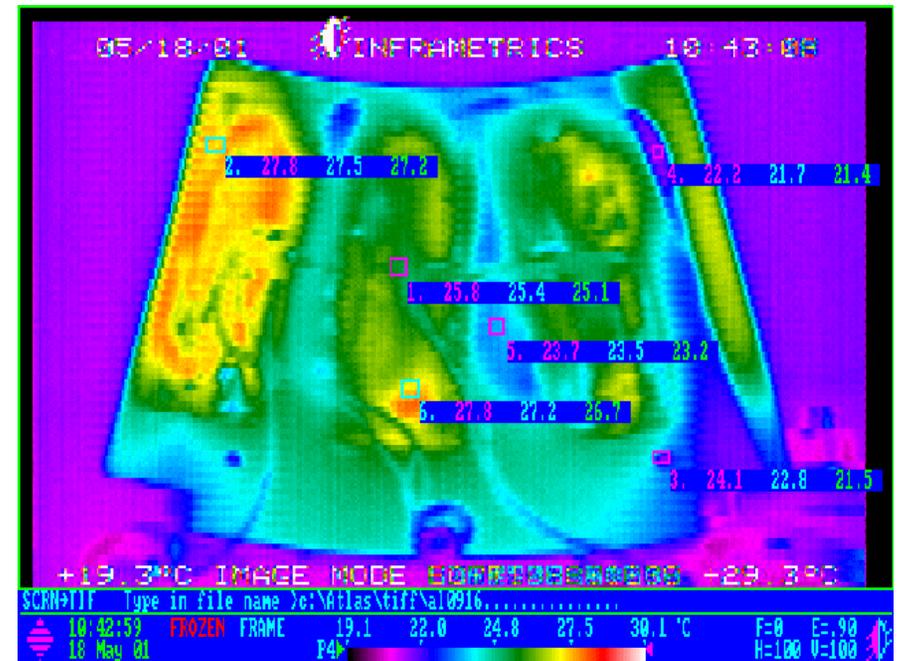


Thermal Performance Summary

- Example at right of pre-rad, one sector
- Typical values of maximum ΔT from coolant to silicon with room temperature water coolant are 6-8C before stress testing.
- Stress testing gives ΔT increase of <2C(usually less)
- Effects of irradiation are ΔT increase of <2C(usually less).
- Expect total maximum ΔT from coolant to silicon to be <12C.

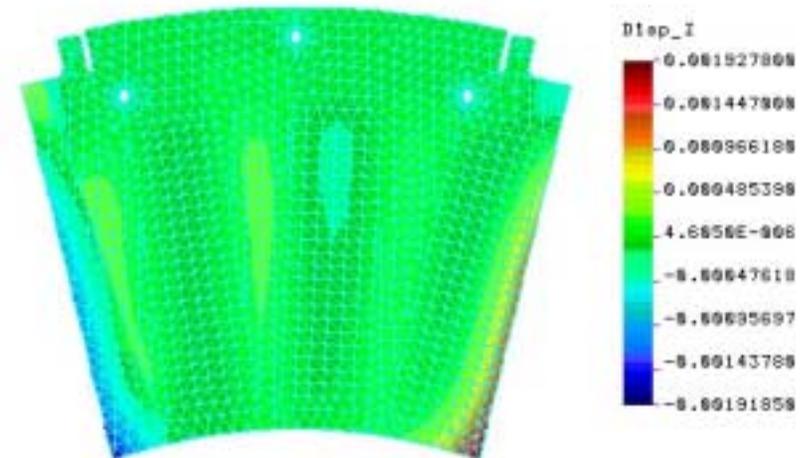
	MAXIMUM $\Delta T(^{\circ}C)$
Baseline	6.9
50 cycles 20<->-35C	7.7
LN2 vapor to -35C	7.6
8 bar for 1 hour	7.6
Repeat 50 cycles 20<->-35C	7.1

Prototype 9 after irradiation(11 Mrads), operation at 150C, thermal shock to -60C

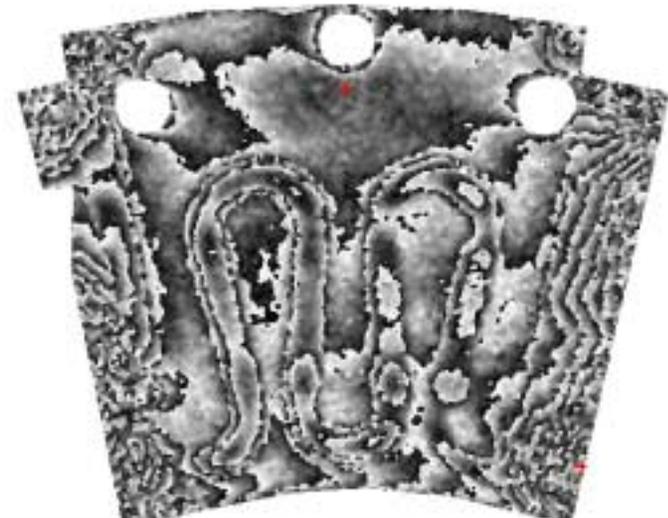


Stability

- Since the FDR, FEA calculations have been done(HTN-106210-0003) to estimate out-of-plane deflections(for which the spec is $<30\mu$ (rms))
- Over most of the sector, FEA indicates deflections of much less than $1\mu/^\circ\text{C}$ (temperature change), rising to about $1\mu/^\circ\text{C}$ only in small regions of the corners.
- TV holographic measurements(and other measurements) confirm the small displacements.



Z distortions for 16°C ΔT in cm



TVH displacement map for 15°C ΔT .
Each fringe is $0.26\ \mu$

Other Studies

- A test piece - 1/3 of a sector - that had been tested previously and irradiated to 50MRad was placed in 100% C₃F₈ vapor (the spec is max of 0.1%), along with samples of CGL-7018 for 3 weeks. No effect on thermal performance. No visual change in CGL material.
- Parylene coating (8-12 microns) covers well the sectors, including the foam. Carbon dust or particles well contained.

Risks and Conclusion

- What are the remaining risks?
 - Attachment of coolant fittings by laser welding demonstrated(backup is glue, also demonstrated). However, final fitting(seal) not selected yet => schedule risk.
 - Mitigation: attach fittings after completion of tube bending. Easy with glue. To be demonstrated with laser welding, working with vendors.
 - Module electrical performance on sector => schedule risk. Modules with prototype 0.25 micron electronics not until early 2002 - see figure.
 - Mitigation: mount and test with existing rad-soft modules, in progress.
- Conclusion
 - Risks acceptable
 - Design validation sufficient
 - Ready to begin (pre)production

